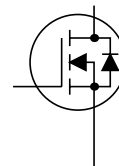
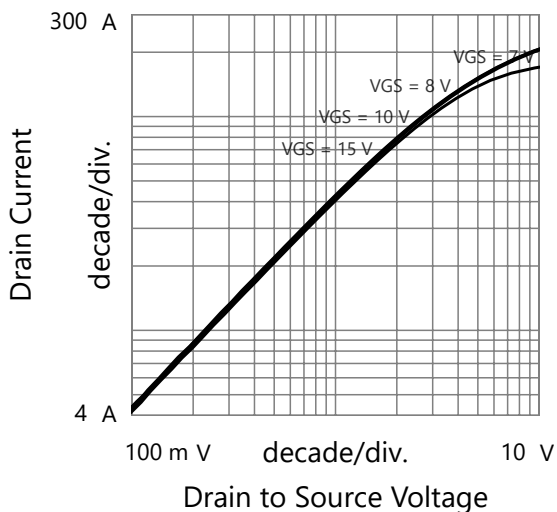


Part Number: 1.IRFP4227PBF
Sample ID: 1A-1
Description: sample
Operator: YM
Measurement Instrument: B1506AH51_MY59200135

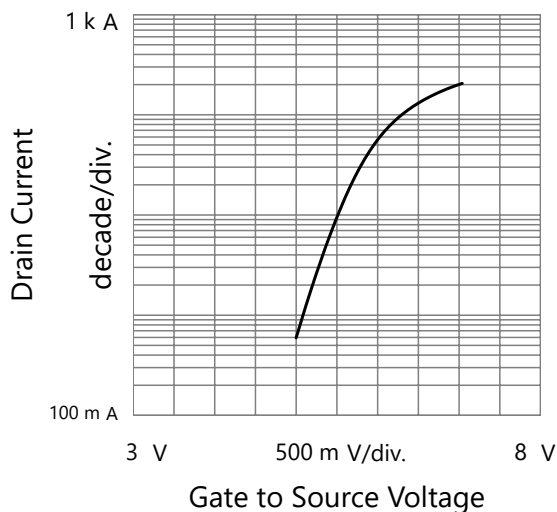


		Maximum Ratings						
Symbol	Parameter	Test Conditions		Value	Unit	Note		
VDSS	Drain to Source Voltage	Tj = -40 °C to 175 °C		200	V			
VGSS	Gate to Source Voltage	Conitnuous		-30 to 30	V			
IDM	Pulsed Drain Current	Tc = 25 °C		260	A			
ISM	Pulsed Body Diode Current	Tc = 25 °C		260	A			
		Characteristics Parameters						
Symbol	Parameter	Test Conditions		Min.	Act.	Max.	Unit	
BVDSS	Drain to Source Breakdown Voltage	VGS = 0 V, ID = 250 μA		200	221		V	
IDSS	Drain Leakage Current	VDS = 200 V, VGS = 0 V			4.99 n	20 μ	A	
IGSS	Gate Leakage Current	VGS = 20 V, VDS = 0 V			18.1 p	100 n	A	
IGSS(-)	Gate Leakage Current (-)	VGS = -20 V, VDS = 0 V		-100 n	-27.9 p		A	
VGS(th)	Gate to Source Threshold Voltage (VDS = VGS)	ID = 250 μA		3	3.98	5	V	
RDS(on)	Drain to Source On Resistance	VGS = 10 V, ID = 46 A, PulseWidth = 200 μs			23.7 m	25 m	ohm	Typ. 21 m ohm
VSD	Body Diode Forward Voltage	VGS = 0 V, IS = 46 A, PulseWidth = 200 μs			850 m	1.3	V	
Rg	Gate Resistance	VGS = 0 V, f = 1 MHz			NaN		ohm	Not specified
Ciss	Input Capacitance	VGS = 0 V, VDS = 25 V, f = 100 kHz			4.69 n		F	Typ. 4600 pF
Coss	Output Capacitance	VGS = 0 V, VDS = 25 V, f = 100 kHz			463 p		F	Typ. 460 pF
Crss	Reverse Transfer Capacitance	VGS = 0 V, VDS = 25 V, f = 100 kHz			141 p		F	Typ. 91 pF
Qg	Total Gate Charge	Vgs(on) = 10 V, Vgs(off) = 0 V, Vds = 100 V, Id = 46 A			82.1 n	98 n	C	Typ. 70 nC
Qgs	Gate to Source Charge	Vgs(on) = 10 V, Vgs(off) = 0 V, Vds = 100 V, Id = 46 A			NaN		C	Not specified
Qgd	Gate to Drain Charge	Vgs(on) = 10 V, Vgs(off) = 0 V, Vds = 100 V, Id = 46 A			28.5 n		C	Typ. 23 nC

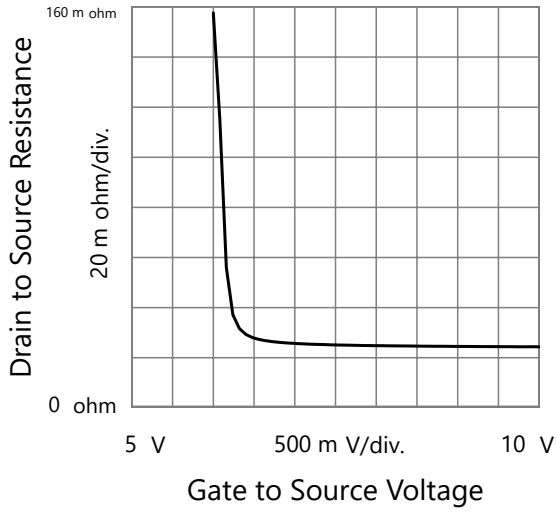
Output Characteristics



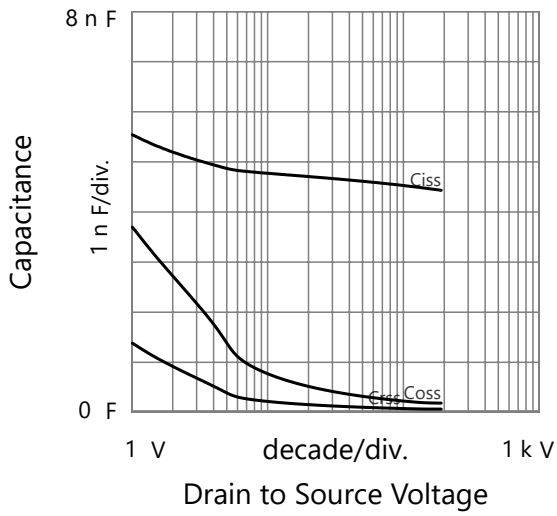
Transfer Characteristics (Vds: 25V @ 200A)



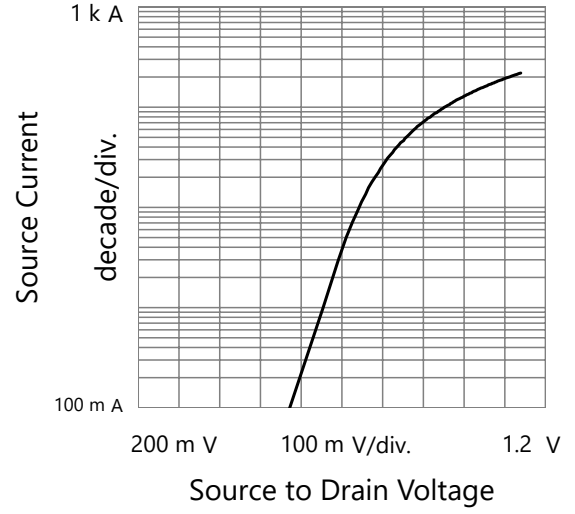
Drain to Source Resistance vs. Gate to Source Voltage



Capacitances



Body Diode Forward Characteristics



Gate Charge (Vds:160 V, Id:46 A)

